# CMP40N20P/CMB40N20P



### N-Channel Enhancement Mode Field Effect Transistor

### **General Description**

The 40N20P uses advanced planar stripe DMOS technology and design to provide excellent RDS(ON). These devices are wellsuited for high efficiency switched mode power supplies,active power factor correction based on half bridge topology.

# **Product Summary**

BVDSS	RDS(on) max.	ID
200V	65mΩ	40A

# Applications

- LED power controller
- DC-DC & DC-AC converters
- High current, high speed switching
- Solenoid and relay drivers
- Motor control, Audio amplifiers

## TO-220/263 Pin Configuration

#### Features

- Fast switching
- Low On-Resistance
- 100% avalanche tested
- RoHS Compliant

# Absolute Maximum Ratings

G D S	GSS	GO
TO-220	TO-263	

Туре	Package Marking	
CMP40N20P	TO-220	CMP40N20P
CMB40N20P	TO-263	CMB40N20P

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	200	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I₀@T₀=25℃	Continuous Drain Current	40	А
I <sub>D</sub> @T <sub>C</sub> =100℃	Continuous Drain Current	32	А
I <sub>DM</sub>	Pulsed Drain Current	160	А
EAS	Single Pulse Avalanche Energy	1000	mJ
P <sub>D</sub> @T <sub>C</sub> =25℃	Total Power Dissipation	160	W
T <sub>STG</sub>	Storage Temperature Range -55 to 175		°C
TJ	Operating Junction Temperature Range	-55 to 175	°C

# **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>0JA</sub>	Thermal Resistance Junction-ambient		62.5	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-case		0.78	°C/W



#### **N-Channel Enhancement Mode Field Effect Transistor**

#### Electrical Characteristics (T\_J=25 $^\circ\!\!\mathbb{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , I <sub>D</sub> =250uA	200			V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =20A			65	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250 uA$	2		4	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =200V , V <sub>GS</sub> =0V			1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = ±20V , $V_{DS}$ =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =28A				S
Qg	Total Gate Charge	I <sub>D</sub> =20A		61		
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DD</sub> =100V		17		nC
Q <sub>gd</sub>	Gate-Drain Charge	V <sub>GS</sub> =10V		19		
T <sub>d(on)</sub>	Turn-On Delay Time			21		
Tr	Rise Time	$V_{DD}$ =50V, $V_{GS}$ =10V		29		20
T <sub>d(off)</sub>	Turn-Off Delay Time	R <sub>G</sub> =2.5Ω		66		115
T <sub>f</sub>	Fall Time	ID=28A		16		
C <sub>iss</sub>	Input Capacitance			2700		
C <sub>oss</sub>	Output Capacitance	$V_{\text{DS}}$ =25V , $V_{\text{GS}}$ =0V , f=1MHz		382		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			50		

## **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	$V_G = V_D = 0V$ , Force Current			40	А
I <sub>SM</sub>	Pulsed Source Current				160	А
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>F</sub> =40A , T <sub>J</sub> =25℃			1.4	V
trr	Reverse Recovery Time	V <sub>GS</sub> =0V, I <sub>F</sub> =20A		185		ns
Qrr	Reverse Recovery Charge	dı⊧ /dt=100A/µs		1.2		μC

Note :

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